

SAD-1024 DUAL ANALOG DELAY LINE

DESCRIPTION:

The SAD-1024 is a general-purpose dual 512-stage Bucket-Brigade Device (BBD) fabricated using N-channel silicon-gate technology to obtain flexible performance at low cost. Each 512-stage section is independent as to input, output, and clock. The sections may be used independently, may be multiplexed to give an increased effective sample rate, may be connected in series to give increased delay, or may be operated in a differential mode for reduced even harmonic distortion at reduced clocking noise. Each section has its output split into two channels so that in normal operation output is provided over each full clock period. The SAD-1024 is packaged in a standard 16-lead dual-in-line package. Only Vdd and GND are common to the two separate delay sections.

KEY FEATURES:

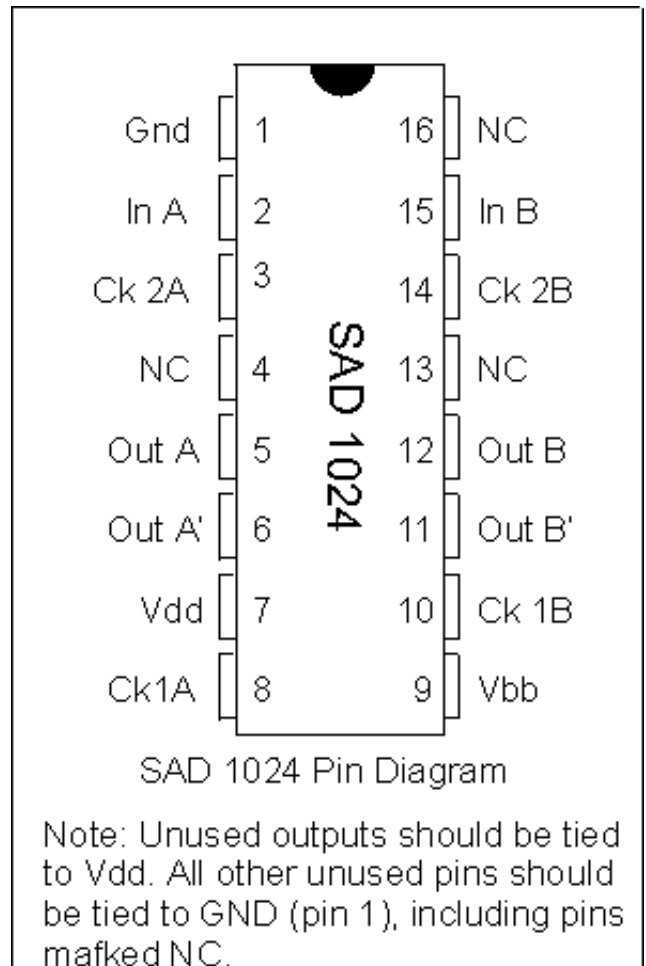
- Two independent 512-stage delay sections.
- Clock-controlled delay: 0.5 sec to less than 200uSec.
- N channel silicon-gate bucket-brigade technology.
- Designed for self-cancellation of clocking modulation.
- Wide signal frequency range: 0 to more than 200kHz.
- Wide sampling clock frequency range: 1.5kHz to more than 1.5MHz.
- Wide dynamic range: S/N > 70db.
- Low distortion: less than 1%.
- Low noise: typically limited by output amplifier.
- Single 15 volt power supply.

TYPICAL APPLICATIONS:

- Voice control of tape recorders.
- Variable signal control of amplitude or of equalization filters.
- Reverberation effects in stereo equipment.
- Tremolo, vibrato, or chorus effects in electronic musical instruments.
- Variable or fixed delay of analog signals.
- Time compression of telephone conversations Of other analog signals.
- Voice scrambling systems.

DEVICE CHARACTERISTICS AND OPERATING PARAMETERS

PARAMETER	Symbol	Min	Typ	Max	Units
Clock Voltage (1)	Ck1, Ck2	10	15	17	Volts
Drain Supply Voltage (1)	Vdd	10	15		Volts
Bias Voltage(1)	Vbb		Vdd-1		Volts
Sampling Freq.	F(Ck1, Ck2)	0.0015		1.5	MHz
Clock Rise-Time	Tcr		30		NSec
Clock Fall Time	Tcf		50		NSec



Clock Line Capacitance	Cc		110		PF
Signal Freq. Bandwidth (-3db point)		(fig 2)	200		KHz
Gain (2)			1.2		
Input Capacitance	Cin		7		Pf
Input Shunt Resistance (3)	Rin				KOHm
Optimum Input Bias (4)			16		Volts
Maximum Input Signal Amplitude		1	2		Volts p-p
Average Temp.Coefficient of Gain (6)			-0.01		Db/C
Average Temp.Coefficient of Optimum Input Bias (6)			0.8		Mv/C
Absolute Maximum Voltage (1)	Any Pin	0.4		+20	

Notes:

1. All voltages measured with respect to GND (pin 1).
2. The value of gain depends on the output termination resistance. See figure 4.
3. Effective a-c shunt resistance measured at 1 Mhz.
4. The input bias voltage varies slightly with the magnitude of the clock voltage (and Vdd) and may be adjusted for optimum linearity at maximum signal level. The value shown is nominal for 15 volt clocks.
5. The device may be operated at clock voltages down to 5 volts (to facilitate use in battery operated portable equipment but with reduced input bias and reduced input signal amplitude).
6. Measured at sample frequency of 10kHz in SAD1024A circuit for temperature range of 0C to 70C.

CAUTION: Static discharge to any lead of this device may cause permanent damage. Store in aluminum foil or inserted in conductive foam. Use grounded soldering irons, tools, and personnel when handling devices. Avoid synthetic fabrics. It is recommended that the device be inserted into socket before applying power.

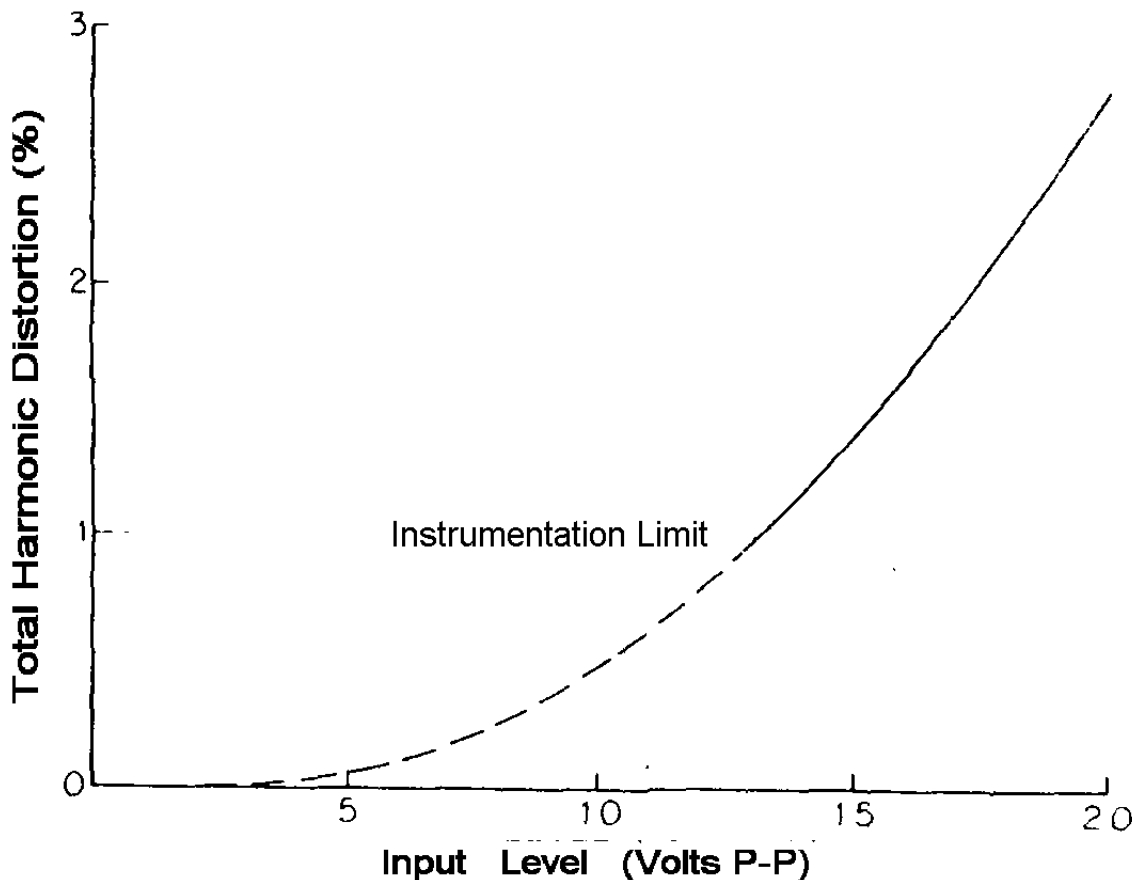


Figure 5. SAD-1024 Distortion vs. Input Level.

SUMMARY OF OPERATION

The SAD-1024 is an analog sampled-data device which uses both linear and digital techniques in its applications and method of use. The input data is handled in analog form in discrete time, and sampled by an external clock. Internally, the data is handled as analog samples but moved at fixed intervals, as in a digital system. The input analog signal is connected to the first of the 512 MOS transistors while the clock frequency is high and is transmitted to the next section when the clock goes low. The amplitude of the input signal remains constant between sections. The clock signals appear at the output as part of the "mix" and must be filtered out.

DRIVE AND VOLTAGE REQUIREMENTS

Voltage levels and limits are given in the Device Characteristics Table. The clock inputs are two-phase square waves. For convenience in use, V_{bb} may be equal to V_{dd} . However, for optimum performance, V_{bb} should be one volt less than V_{dd} . All unused outputs should be connected to V_{dd} . All unused terminals (including the ones marked NC) should be connected to ground. The bandwidth of the input should be limited to less than one-half of the clock frequency.

CLOCKING

The SAD-1024 requires a two phase, non-overlapping clock signal. In general, the clock timing requirements are simple enough that typical CMOS logic gates can satisfy the non-overlapping requirements with a simple inverter chain. CMOS flip-flops such as the CD4013 provide an excellent clock source with their Q and -Q outputs.

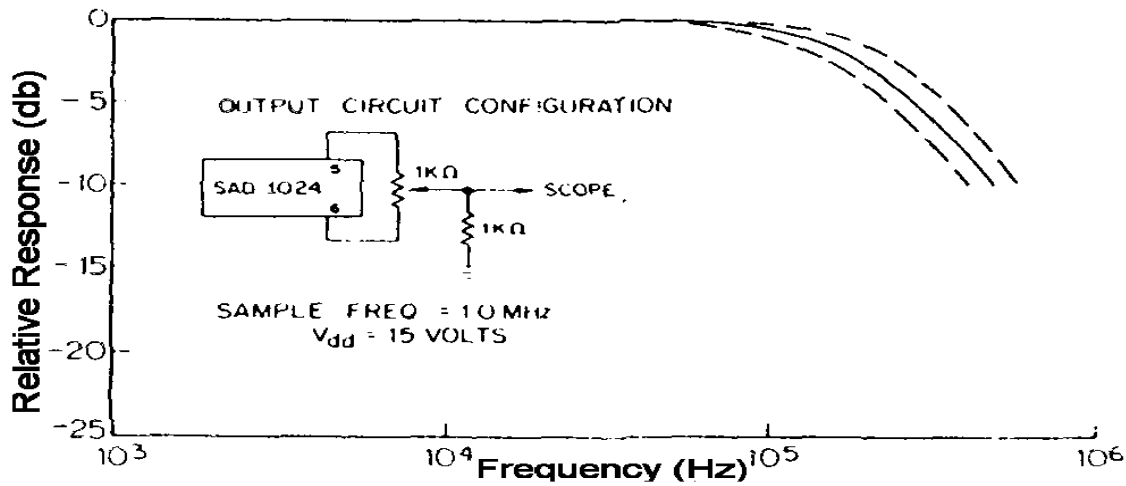


Figure 3. Frequency Response showing Typical Variation Device to Device.

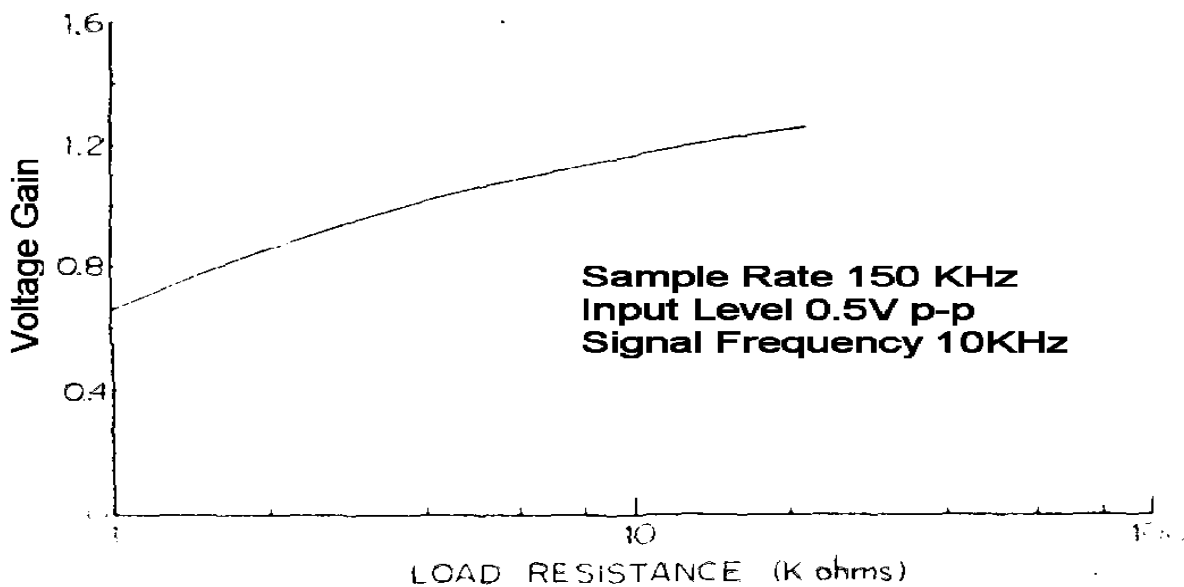


Figure 4. Dependence of Gain on Load Resistance.

CIRCUIT CONFIGURATIONS

The SAD-1024 consists of two 512 element delay sections which, except for common grounds and power input are electrically independent. The sections may be used in the following configurations:

1. Single-section
2. Serial
3. Parallel-multiplex
4. Differential
5. Multiple-devices in series